Application/Control No. Applicant(s)/Patent Under Reexamination 09/474,783 NEWELL ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Annan Q. Shang 2617 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 08-1998 US-5,796,828 Tsukamoto et al. 380/203 Α US-В С US-D US-Ε US-US-US-G US-Н US-Т US-J USκ US-US-**FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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